# MOSFET – Power, Single N-Channel, μCool, 2.0x2.0x0.55 mm UDFN6 30 V, 10.7 A

## **Features**

- Low Profile UDFN 2.0 x 2.0 x 0.55 mm for Board Space Saving with Exposed Drain Pads for Excellent Thermal Conduction
- Ultra Low R<sub>DS(on)</sub> to Reduce Conduction Losses
- Optimized Gate Charge to Reduce Switching Losses
- Low Capacitance to Minimize Driver Losses
- NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

- Power Load Switch
- Synch DC-DC Converters
- Wireless Charging Circuit

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	30	V
Gate-to-Source Vol	tage		$V_{GS}$	±20	V
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	10.7	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C		7.7	
	t ≤ 5 s	T <sub>A</sub> = 25°C		15.1	
Power Dissipa- tion (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.54	W
	t ≤ 5 s	T <sub>A</sub> = 25°C		3.1	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	6.8	Α
Current (Note 2)	State	T <sub>A</sub> = 85°C		4.9	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	$P_{D}$	0.63	W
Pulsed Drain Current t <sub>p</sub> = 10		t <sub>p</sub> = 10 μs	I <sub>DM</sub>	43	Α
MOSFET Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Source Current (Body Diode) (Note 1)			Is	1.55	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

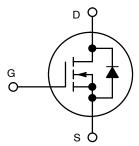


# ON Semiconductor®

## www.onsemi.com

## MOSFET

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	9 mΩ @ 10 V	
	12 mΩ @ 4.5 V	10.7.4
	15 mΩ @ 3.7 V	10.7 A
	19 mΩ @ 3.3 V	



**N-CHANNEL MOSFET** 

#### MARKING DIAGRAM





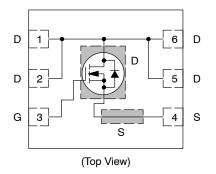
AG = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

## **PIN CONNECTIONS**



## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

2.	. Surface-mounted on FR4 board using the minimum recommended pad size, 2 oz. Cu.				

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	81	
Junction-to-Ambient – t ≤ 5 s (Note 3)	$R_{\theta JA}$	40.5	°C/W
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\theta JA}$	200	

- 3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- 4. Surface-mounted on FR4 board using the minimum recommended pad size, 2 oz. Cu.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref to 25°C			12		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			1.0	μΑ
Cata ta Cauraa Laaliana Currant		\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	T <sub>J</sub> = 125°C	+		10	^
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V$ ,	V <sub>GS</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)			1 050 1	1 40		0.4	1 1/
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	, I <sub>D</sub> = 250 μA	1.3		2.1	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.8		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>		V, I <sub>D</sub> = 9.0 A		7.2	9	mΩ
			V, I <sub>D</sub> = 8.0 A		9.3	12	
			V, I <sub>D</sub> = 5.0 A		10.9	15	
			V, I <sub>D</sub> = 5.0 A		13	19	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 15 \	V, I <sub>D</sub> = 9.0 A		39		S
CHARGES, CAPACITANCES & GATE	RESISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			1172		pF
Output Capacitance	C <sub>OSS</sub>				546		
Reverse Transfer Capacitance	C <sub>RSS</sub>	• • • • • • • • • • • • • • • • • • • •	- 10 V		26		1
Total Gate Charge	Q <sub>G(TOT)</sub>				8.4		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 8.0 A			1.1		
Gate-to-Source Charge	Q <sub>GS</sub>				3.0		
Gate-to-Drain Charge	$Q_{GD}$				2.2		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 9.0 A			18		nC
SWITCHING CHARACTERISTICS, VG	S = 4.5 V (Note 6)	l.					<u>I</u>
Turn-On Delay Time	t <sub>d(ON)</sub>				9.4		ns
Rise Time	t <sub>r</sub>	Voc = 45 V	/ Voo = 15 V		15		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 4.5 V, $V_{DD}$ = 15 V, $I_{D}$ = 8.0 A, $R_{G}$ = 3 $\Omega$			14		
Fall Time	-u(OFF)			<del>                                     </del>	3.5		
SWITCHING CHARACTERISTICS, VG		l			1		
Turn-On Delay Time	t <sub>d(ON)</sub>			1	6.3		ns
Rise Time	t <sub>r</sub>		\/ 15\/	<del>                                     </del>	14		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 15 \text{ V},$ $I_{D} = 9.0 \text{ A}, R_{G} = 3 \Omega$		+	18		
Fall Time	t <sub>f</sub>			<del>                                     </del>	2.4		
i dii iiiilo	ч				۷.٦		

- 5. Pulse Test: pulse width  $\leq$  300  $\mu\text{s},$  duty cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ndition	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.5 A	T <sub>J</sub> = 25°C		0.72	1.1	V
		I <sub>S</sub> = 1.5 A	T <sub>J</sub> = 125°C		0.52		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dls/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 1.5 \text{ A}$			29		ns
Charge Time	t <sub>a</sub>				14.1		
Discharge Time	t <sub>b</sub>				14.9		
Reverse Recovery Charge	Q <sub>RR</sub>				20		nC

- 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.

# **TYPICAL CHARACTERISTICS**

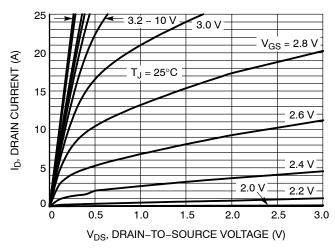


Figure 1. On-Region Characteristics

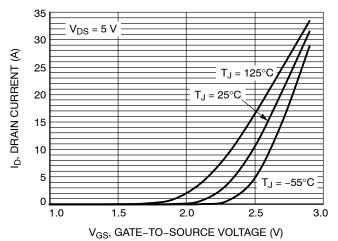


Figure 2. Transfer Characteristics

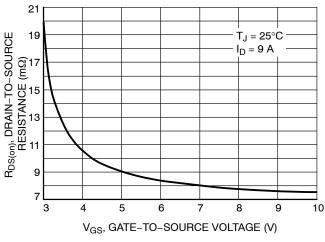


Figure 3. On-Resistance vs. Gate-to-Source Voltage

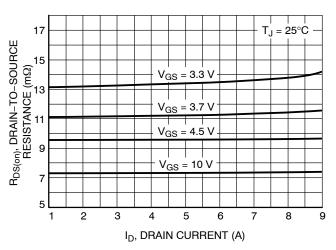


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

## **TYPICAL CHARACTERISTICS**

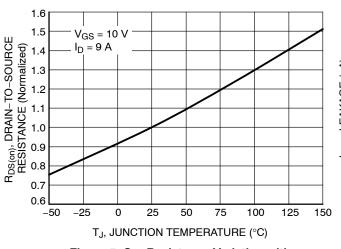


Figure 5. On–Resistance Variation with Temperature

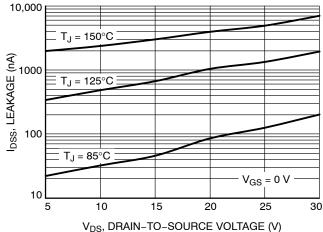


Figure 6. Drain-to-Source Leakage Current vs. Voltage

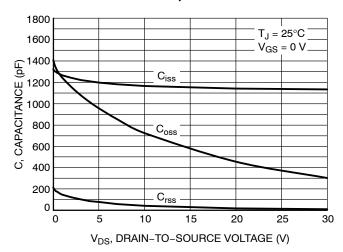


Figure 7. Capacitance Variation

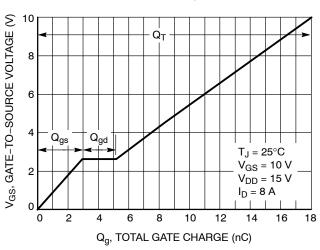


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

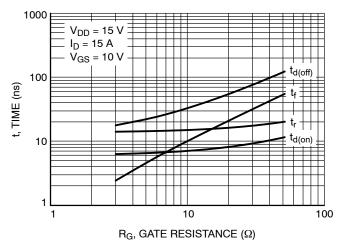


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

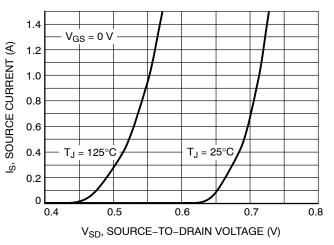


Figure 10. Diode Forward Voltage vs. Current

## **TYPICAL CHARACTERISTICS**

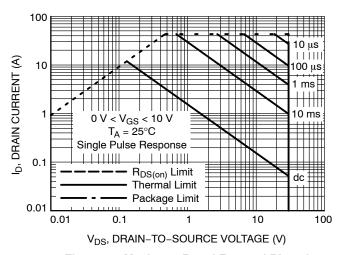


Figure 11. Maximum Rated Forward Biased Safe Operating Area

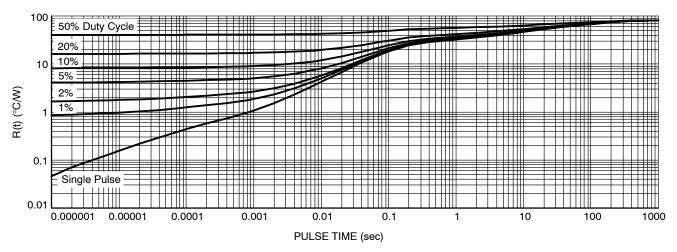


Figure 12. Thermal Response

# **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVLUS4C12NTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

DETAIL A

6X L

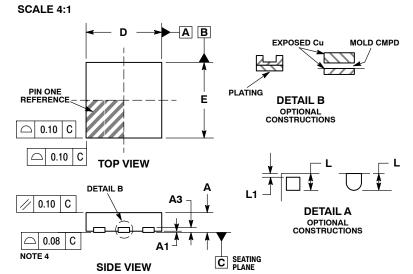
**E2** 

J1

**BOTTOM VIEW** 



**DATE 04 FEB 2010** 



C 0.10

0.05 C NOTE 5

NOTE 3

Ф

0.10 С Α

С 0.05

Α



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION & APPLIES TO PLATED TERMINAL AND IS
  MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL
  COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS
  THE TERMINALS. 3.
- 1. CENTER TERMINAL LEAD IS OPTIONAL CENTER TERMINAL IS CONNECTED TO TERMINAL LEAD # 4.
  2. LEADS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

	MILLIMETERS				
DIM	MIN	MAX			
Α	0.45	0.55			
A1	0.00	0.05			
A3	0.13	REF			
b	0.25	0.35			
b1	0.51	0.61			
D	2.00 BSC				
D2	1.00 1.20				
E	2.00 BSC				
E2	1.10	1.30			
е	0.65	BSC			
K	0.15	REF			
J	0.27 BSC				
J1	0.65 BSC				
L	0.20	0.30			
L1		0.10			
L2	0.20 0.30				

# **GENERIC MARKING DIAGRAM\***



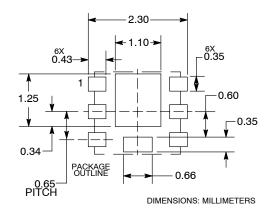
XX = Specific Device Code

M = Date Code

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present.

## RECOMMENDED **MOUNTING FOOTPRINT**



DOCUMENT NUMBER:	98AON48158E	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	UDFN6 2X2, 0.65P		PAGE 1 OF 1		

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

ON Semiconductor and the are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

ON Semiconductor Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative